# Stitch-avoiding Global Routing for Multiple E-Beam Lithography

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Abstract-In Multiple E-Beam Lithography (MEBL), a layout of an IC is partitioned into vertical stripes whose boundaries are called stitch-lines. Routing patterns in each stripe are written by different beams and/or in different writing passes. However, patterns cut by stitch-lines suffer from overlay errors resulting in severe pattern distortions. These distortions are mainly due to Via violation, Vertical Routing violation, or Short Polygon. In this paper, we have proposed a Stitch-avoiding Global Router. The proposed method selects the best possible global routing path for each net so that even a traditional detailed router can generate a Detailed Routing solution with fewer violations. Experimental results show that our proposed global router followed by a conventional detailed router generates solutions with 17.3%, 6.21% and 1.89% reduction in Via violations, Short polygon violations and routed wirelength respectively with no vertical routing violations, compared to those by traditional global routing.

Index Terms—Multiple e-beam lithography (MEBL), global routing, stitch-line, via violation, short polygon

#### I. INTRODUCTION

The decrease in feature size of modern ICs has led to Next-Generation Lithography (NGL) techniques such as Electron Beam Lithography (EBL) [1], Multiple E-Beam Lithography (MEBL) [2], Extreme Ultra-Violet Lithography (EUVL) to overcome the limitations of 193 nm immersion lithography. By using thousands or even millions of e-beams in parallel, MEBL overcomes the low throughput of EBL [1]. A layout is divided into vertical stripes (Fig.1(a)), where the boundaries are called stitch-lines [2]. Routing patterns in different stripes are printed by different beams simultaneously and/or in different printing passes. Routing comprises global routing, layer assignment and detailed routing, and hence poses challenges in MEBL, as deflection of two adjacent e-beams produces overlay errors [2] on the patterns cut by stitch-lines (Figs. 1(b) and (c)). Patterns suffering from overlay errors are called critical patterns. Overlay errors cause severe pattern distortions and electrical violations, thereby poor circuit performance or even fabrication defects.

During routing in MEBL, utmost attention should be paid to critical patterns. A *stitch-unfriendly region*  $\tau$  [2] is the area within a horizontal distance  $\epsilon$  from a vertical stitch-line. Authors in [2] identified three types of violations causing bad patterns, namely (Fig.1(d)) 1) Via violation: vias on stitch-lines, 2) Vertical Routing violation: vertical routing on stitch-lines, and 3) Short Polygon violation: a horizontal wire segment cutting a stitch-line and landing on a stitch-unfriendly

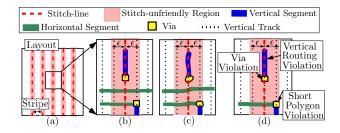


Fig. 1. (a) Stitch-lines in a layout, (b) patterns cut by stitch-lines, (c) pattern distortion due to overlay error, and (d) violations due to a stitch-line.

region with a leading via is defined as a short polygon [2]. Severe pattern distortions can occur due to the existence of vias and vertical routing violations, hence these are considered as hard constraints, whereas short polygon as a soft constraint as it may not always lead to pattern distortion [2]. Hence, during routing, these violations need to be minimized.

Wire perturbation-based approach of rerouting nets in [3] reduces stitch-line violations, but in the post routing phase on a pre-routed layout. The perturbations may not avoid all stitch-line violations for a congested and large circuit. The approach in [2] used a traditional global router with a new congestion constraint and reduced the violations mainly in the detailed routing phase. As detailed routing is largely dependent on global routing, it is pertinent to design a dedicated global router for MEBL in order to obtain a detailed routing with no stitch-line violations.

In this paper, we propose a stitch-avoiding global router for MEBL that considers stitch-lines while obtaining a global routing solution such that even a traditional detailed router can generate routing with minimum stitch-line violations. Experimental results of our proposed global router on the Faraday [4] benchmark suite show a significant reduction in the stitch-line violations.

The rest of the paper has the preliminaries, problem formulation and framework of our proposed method in Section II. Sections III and IV present Phase I and II of our global router. Section V provides the experimental results and Section VI the concluding remarks.

#### II. STITCH-AVOIDING GLOBAL ROUTING

# A. Preliminaries

A grid graph model represents an instance of global routing by a grid graph G = (V, E) where V is the set of vertices such

that a vertex  $v_r \in V$  represents the global grid cell (*G-cell*)  $c_r$ , and  $E = \{e_{rs}\}$  is the set of edges. If G-cells  $c_r$  and  $c_s$  are adjacent to each other, then  $e_{rs} = \{v_r, v_s\} \in E$ . Each  $e_{rs}$  has routing capacity  $C_{rs}$ , the maximum number of segments that are allowed to cross the boundary between G-cells  $c_r$  and  $c_s$ .

A G-cell containing stitch-line is a stitch holding cell.

Stitch-avoiding routing capacity  $C_{rs}^{Stitch}$  of edge  $e_{rs}$  is defined as  $C_{rs}^{Stitch} = (C_{rs} - |L|)$  if  $e_{rs}$  is a vertical edge and  $c_r$ ,  $c_s$  both are stitch holding cells, where |L| is the number of vertical layers.  $C_{rs}^{Stitch} = C_{rs}$  otherwise.

Available stitch-avoiding routing capacity  $A_{rs}^{Stitch}$  of edge  $e_{rs}$  is defined as  $(C_{rs}^{Stitch}-U_{rs})$  where  $U_{rs}$  is the number of net segments that pass through the G-cell boundary corresponding to edge  $e_{rs}$ .

Stitch-avoiding vertex capacity  $C_r^{Stitch}$  is the maximum number of pins or vias that are allowed in the G-cell  $c_r$ .

Available stitch-avoiding vertex capacity  $A_r^{Stitch}$  of vertex  $v_r$  is defined as  $(C_r^{Stitch} - U_r)$  where  $U_r$  is the number of pins or vias in G-cell  $c_r$ .

Let the netlist to be routed be  $\mathcal{N}=\{N_1,N_2,....,N_n\}$ . Depending on the number of pins in a net  $N_i$ , the nets are considered in two categories, namely (a) *multi-pin Nets*, and (b) *two-pin Nets*. Depending on the position of the pins, two sub-categories are identified for two-pin nets as follows:

- A two-pin net  $N_i$  is called a *Flat net* if the two pins  $P_1^i$  and  $P_2^i$  are in G-cells  $v_r$  and  $v_s$  respectively and the G-cells corresponding to  $v_r$  and  $v_s$  are in the same row or column of G-cell grid.
- A two-pin net  $N_i$  is called a *Bend net* if the two pins  $P_1^i$  and  $P_2^i$  are in G-cells  $v_r$  and  $v_s$  respectively that are not in same row or column and there are several paths consisting of a sequence of horizontal and vertical segments to connect the pins present in  $v_r$  and  $v_s$ .

#### B. Problem Formulation

The proposed stitch-avoiding global routing problem using grid graph model with  $C_{rs}^{Stitch}$  and  $C_r^{Stitch}$  is formulated as follows:

Given a netlist  $\mathcal{N}=\{N_1,N_2,....,N_n\}$ , locations of stitch-lines  $S=\{S_1,S_2,....,S_l\}$  and the routing grid graph G=(V,E), find a set of stitch-avoiding rectilinear paths  $\Gamma=\{\Gamma_1,\Gamma_2,...,\Gamma_n\}$  for every net in the netlist  $\mathcal{N}$  such that the constraints for stitch-avoiding global routing and vertex capacity are not violated, i.e.,  $U_{rs} \leq C_{rs}^{Stitch} \ \forall e_{rs} \in E$ ,  $U_r \leq C_r^{Stitch} \ \forall v_r \in V$ , and the total path length  $\Sigma_{i=1}^n |\Gamma_i|$  is minimized, where  $|\Gamma_i|$  is the length of the path of net  $N_i$ .

## C. Proposed Global Routing Framework

A state-of-the-art global router with only non-uniform G-cell capacities cannot ensure reductions in stitch-line violations as these depend on the position of the stitch-lines, pins, Steiner points, vias and segments. These factors need to be considered during global routing to assign global routing paths efficiently which would consequently guide the detailed router to minimize violations. Fig. 2 shows the framework of our proposed stitch-avoiding global router inspired by *BoxRouter* [5]. It has two phases, namely, (a) Stitch-avoiding Steiner

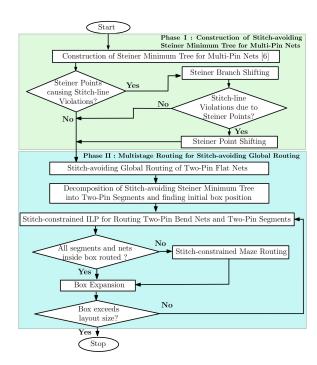


Fig. 2. Framework of Stitch-avoiding Global Routing

Minimum Tree (SSMT) generation followed by (b) multistage stitch-avoiding global routing, which are presented in the next two sections.

#### III. STITCH-AVOIDING STEINER MINIMUM TREE (SSMT)

For each multi-pin net, we use FLUTE [6] to generate an initial Steiner Minimum Tree (SMT). This SMT may contain Steiner points on the stitch-lines producing via and vertical routing violations, or on the stitch-unfriendly region causing short polygon violation. Two shifting mechanisms namely Steiner Branch Shifting (SBS) and Steiner Point Shifting (SPS) are performed to avoid these violations. Shifting techniques are used in [7] to get a congestion-aware SMT. However, in this work, stitch-line violations are minimized by shifting a Steiner branch or point out of the stitch-unfriendly region only if it causes a stitch-line violation.

In SBS, a branch of SMT whose both endpoints are Steiner points and lies in a stitch-unfriendly region is a candidate for shifting (see Figs. 3(a) and (b)). In case of SPS, a Steiner point is considered for shifting if it is on a stitch-line or in a stitch-unfriendly region, and one of its connected branches crosses a stitch-line (see Figs. 3(c) and (d)).

As stitch-lines are assumed to be vertical, both SBS and SPS search horizontally for a suitable location to shift a candidate Steiner tree branch or point outside the stitch-unfriendly region. SBS searches for a routing region with sufficient routing capacity outside the nearer boundary of the stitch-unfriendly region. If no such routing region can be found, then it searches towards the farther boundary of the stitch-unfriendly region. If no suitable routing region exists which can hold the branch due to capacity constraints, this

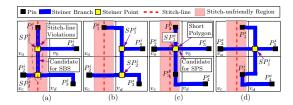


Fig. 3. (a) Steiner branch between  $SP_1^i$  and  $SP_2^i$  causing via and vertical routing violations, (b) violations removed after SBS, (c) Steiner Point  $SP_1^i$  causing short polygon violation, and (d) short polygon removed after SPS.

violation cannot be eliminated during global routing. SPS uses line probing method to shift a candidate Steiner point.

#### IV. MULTISTAGE STITCH-AVOIDING GLOBAL ROUTING

Once SSMTs have been generated, the ordering of the nets for global routing is first the two-pin flat nets which are less flexible, then the two-pin bend nets and multi-pin nets.

#### A. Stitch-avoiding Global Routing of Two-Pin Flat Nets

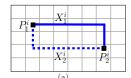
Two-pin flat nets have only one shortest path between the two pins, either horizontally or vertically spanned. These nets are routed using a shortest path algorithm on G with available routing resource  $A_{ij}^{stitch}$  as edge weight. However, some of the vertically spanned nets may reside in stitch holding cells, which need careful resource utilization inside them. These vertically spanned two-pin flat nets are routed by using our proposed stitch-constrained maze routing described below in Section IV.C.

# B. Stitch-avoiding Global Routing of Two-Pin Bend Nets (TPBN) and Multi-Pin Nets

The SSMT for each multi-pin net is decomposed into two-pin segments (TPS). These two-pin segments can be either Two-pin Flat Segment (TPFS) or Two-pin Bend Segment (TPBS). Along the lines of *BoxRouter* [5], we define a box on the layout containing multiple *G*-cells. In our method, the four most densely populated contiguous *G*-cells comprise the initial box. A stitch-constrained Integer Linear Programming (ILP) followed by Stitch-constrained Maze Routing are used to route the TPBNs and TPSs residing in the current box. Next, the box is iteratively expanded to include new *G*-cells and new nets. In the next iteration, the newly included nets and only the previously unrouted nets are considered for stitch-avoiding global routing by solving a corresponding stitch-constrained ILP followed by Stitch-constrained Maze Routing. This process is repeated until the box covers the entire layout.

In each iteration, only the TPBNs and TPSs (both TPFSs and TPBSs) that are present inside the current box are routed, so the size of the ILP is small. Hence, solving ILPs for each box does not become a time-consuming task. We can also control the amount of expansion of the current box depending on the density of nets present in the circuit.

A number of constraints and weights are used in the ILP to generate a solution that minimizes stitch-line violations. Let us consider routing of the TPBNs and TPSs of  $k^{th}$  box which contains the following three categories of nets and segments:



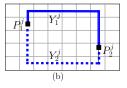


Fig. 4. Two patterns for a net of (a) Category 1 (b) Category 2

- Category 1: TPBNs and TPSs newly included in the k<sup>th</sup> hox
- Category 2: Unrouted TPBNs and TPSs in the ILP solution for the  $(k-1)^{th}$  box.
- Category 3: Unrouted TPBNs and TPSs in the ILP solution for the  $(k-2)^{th}$  and  $(k-1)^{th}$  boxes.

Let  $NET_k$  be the set of  $n_1$  Category 1 and  $n_2$  Category 2 TPBNs and TPBSs present inside the  $k^{th}$  box. Let  $NET_k^{Flat}$  be the set of  $n_3$  Category 1 TPFSs present inside the  $k^{th}$  box.

As shown in Fig. 4(a), for  $Category\ 1$ , only two L-shaped patterns are considered for each TPBN and TPBS to reduce routing bends in the stitch-constrained ILP, because new vias introduced by bends may increase stitch-line violations. Let  $X_1^i$  and  $X_2^i$  denote the two L-shaped routing patterns of net  $N_i$ . However, only one horizontal or vertical pattern is considered for TPFS and is denoted by  $X_1^i$ . In our proposed stitch-constrained ILP, weights are assigned to  $X_1^i$  and  $X_2^i$  in the objective function as follows:

a) Weight depending on length and type of net: Small nets are less flexible, hence need to be routed first. We consider the Manhattan Distance (MD) between the endpoints of each net in the weight function. TPBNs are less flexible than TPSs as both of their endpoints are fixed pins. Hence, a higher weight is assigned to TPBNs. The weight  $\gamma^i$  for net  $N_i$  depending on its length and category, is defined as

$$\gamma^{i} = \left\lceil \frac{\sum_{N_{j} \in NET_{k} \cup NET_{k}^{Flat}} MD(N_{j})}{(n_{1} + n_{2} + n_{3}).MD(N_{i})} \right\rceil + FPins(N_{i})$$
 (1)

where  $FPins(N_i)$  is the number of fixed pins in net  $N_i$ .

b) Weight depending on routing congestion and the position of endpoints with respect to stitch-lines: To improve routability, the ratio of MinAvailableCapacity, the minimum available capacity and MaxDemand, the maximum demand along a path  $X_f^i$  ( $f=1\ or\ 2$ ), is the weight to route the net through less congested region. Depending on the position of the endpoints of the TPBNs and TPBSs with respect to stitch-lines, different priorities are given to  $X_1^i$  and  $X_2^i$ . The priorities of  $X_f^i$  for f=1 or 2, is denoted by  $\alpha_f^i$ .

Let  $P_1^i$  and  $P_2^i$  be the two endpoints of the net  $N_i$ . Depending on the position of stitch-lines with respect to the pin positions, Algorithm 1 computes  $\alpha_1^i$  and  $\alpha_2^i$  for TPBNs and TPBSs. If  $\alpha_1^i$  is assigned a higher value than  $\alpha_2^i$ , then path  $X_1^i$  is more suitable than path  $X_2^i$  in the presence of stitch-lines and vice-versa. No preference exists for TPFSs, as only one path is considered. Hence, for TPFSs, we set  $\alpha_1^i = 1$ .

Figure 5(a) shows an example of a situation that falls under Case I of Algorithm 1. It shows two candidate L-shaped paths for net  $N_i$  denoted as  $X_1^i$  and  $X_2^i$ . The pin position with respect

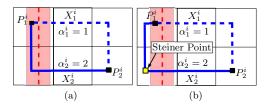


Fig. 5. (a) Value of  $\alpha_1^i$  and  $\alpha_2^i$  under a situation; (b) Making path  $X_2^i$ violation free by introducing new Steiner Point

to stitch-line satisfies the condition  $t_1 = true \land t_2 = false \land$  $x(P_1^i) < S_1$  of Case I where  $S_1 = xStitch(P_1^i)$ . Now, if we choose the path  $X_1^i$ , then a short polygon is generated at  $P_1^i$ . Two cases can occur:  $P_1^i$  can be either a fixed pin or a Steiner point. The presence of a Steiner point inside the stitchunfriendly region indicates that both SBS and SPS were unable to move the Steiner point out of the stitch-unfriendly region due to the unavailability of required space outside the stitchunfriendly region. Under this situation, we can also consider the Steiner point as unmovable. Hence, whether  $P_1^i$  is a fixed pin or an unmovable Steiner point, we cannot eliminate the short polygon at  $P_1^i$ .

If we choose the path  $X_2^i$ , then there is no short polygon at  $P_1^i$ . However, during detailed routing, we may need to introduce a via at the junction of horizontal and vertical segment of  $X_2^i$ . Further, if the vertical segment of  $X_2^i$  is assigned to a track inside the stitch-unfriendly region, then the newly introduced via generates a short polygon violation. We can avoid this situation in the global routing phase itself. We introduce a Steiner point outside the stitch-unfriendly region as shown in Fig. 5(b) and thus prevent the short polygon violation from occurring. Hence, we assign  $\alpha_1^i = 1$  and  $\alpha_2^i = 2$  to give higher priority to path  $X_2^i$  than path  $X_1^i$ .

The total weight of  $X_f^i$  for f = 1 or 2, is defined as

$$w_f^i = \gamma^i + \alpha_f^i \left[ \frac{MinAvailableCapacity(X_f^i)}{MaxDemand(X_f^i)} \right] \qquad (2)$$

Category 2 TPBNs and TPBSs not being routed during  $(k-1)^{th}$  iteration, implies that the routing resources are not enough for routing with only the L-shaped patterns. More bends are necessary to route these TPBNs and TPBSs. We consider two patterns with two bends as shown in Fig. 4(b). These two patterns are denoted by  $Y_1^j$  and  $Y_2^j$  for net  $N_i$ . These paths have one more bend and a wirelength overhead over Category 1 TPBNs and TPBSs. Hence, a penalty  $\varphi$  is subtracted from the weight of  $Y_1^j$  and  $Y_2^j$ .

TPBNs and TPSs in Category 3 are not considered in the  $k^{th}$  box for routing and are routed later by stitch-constrained maze routing described in Section IV.C.

The generalized stitch-constrained ILP to route the nets inside  $k^{th}$  box is presented in Fig. 6. Consider  $E_{Box^k}$  and  $V_{Box^k}$  to be the set of edges and vertices of G that are present in the  $k^{th}$  box respectively. The objective function specified in Eqn. 3 is to maximize the number of routed nets by choosing candidate paths  $X_f$ ,  $Y_q$  and  $X_l$  for Category 1 and Category 2 TPBNs, TPBSs and TPFSs present in the  $k^{th}$  Box such that

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Algorithm 1: Finding \alpha_1^i and \alpha_2^i
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Input: NET_k: TPBNs and TPBSs inside box k.
   Output: Weights \alpha_1^i, \alpha_2^i for all N_i \in NET_k
1 for each net N_i \in NET_k do
        Set t_1 = \tau Check(P_1^i), t_2 = \tau Check(P_2^i);
          /* \ 	au Check(P_f^i) returns true \ {\it if} \ P_f^i \ {\it is} \ {\it inside} \ {\it a}
         stitch-unfriendly region and false
         otherwise for f=1 or 2 */
        Set S_1 = xStitch(P_1^i), S_2 = xStitch(P_2^i);
         /\star xStitch(P_f^i) returns the x-coordinate of
         the stitch-line present in the cell where
         pin P_f^i resides. */
        Case I : Set \alpha_1^i = 1, \alpha_2^i = 2 If
         (t_1 = true \wedge t_2 = false \wedge x(P_1^i) < S_1) \, \vee \,
         (t_1 = false \wedge t_2 = true \wedge x(P_2^i) < S_2) \vee
         (t_1 = true \land t_2 = true \land x(P_1^i) < S_1 \land x(P_2^i) < S_2);
          /\star~x(P_{\scriptscriptstyle f}^i) returns the x-coordinate of P_{\scriptscriptstyle f}^i and
         assume w.l.o.g. that x(P_1^i) \leq x(P_2^i) */
        Case II : Set \alpha_1^i = 2, \alpha_2^i = 1 If
         (t_1 = true \land t_2 = false \land x(P_1^i) > S_1) \lor
         (t_1 = false \land t_2 = true \land x(P_2^i) > S_2) \lor
         (t_1 = true \land t_2 = true \land x(P_1^i) > S_1 \land x(P_2^i) > S_2);
        Case III : Set \alpha_1^i = 1, \alpha_2^i = 1 otherwise;
7 end
```

the constraints are satisfied. Eqns. 4 and 5 restrict the ILP solver to choose at most one candidate path for each TPBN and TPBS of Category 1 and 2 respectively. Eqn. 6 allows the ILP solver to select a particular TPFS depending on the value of the objective function and other constraints. Eqns. 7 and 8 in the ILP impose routing and vertex capacity constraints.

### C. Stitch-constrained Maze Routing

After solving the ILP for the  $k^{th}$  box, the unrouted twopin flat nets and the Category 3 TPBNs and TPSs in the  $k^{th}$  box are routed. More bends are needed for routing these unrouted nets. Hence, we use stitch-constrained Maze Router

$$\max \sum_{i=1}^{n_1} \sum_{f=1}^{2} w_f^i X_f^i + \sum_{j=1}^{n_2} \sum_{q=1}^{2} (w_q^j - \varphi) Y_q^j + \sum_{l=1}^{n_3} w_1^l X_1^l$$
 (3)

$$X_1^i + X_2^i \le 1$$
  $\forall N_i \in (NET_k \backslash NET_{k-1})$  (4)

$$Y_1^j + Y_2^j \le 1 \qquad \forall N_i \in (NET_k \cap NET_{k-1}) \tag{5}$$

$$\begin{split} X_1^i + X_2^i &\leq 1 & \forall N_i \in (NET_k \backslash NET_{k-1}) & (4) \\ Y_1^j + Y_2^j &\leq 1 & \forall N_j \in (NET_k \cap NET_{k-1}) & (5) \\ X_1^l &\leq 1 & \forall N_l \in NET_k^{Flat} & (6) \end{split}$$

for each  $e_{rs} \in E_{Box^k}$ ,  $X_f^i, Y_q^i$  intersects  $e_{rs}$ 

$$\sum_{e_{rs}} (X_f^i + Y_q^i) \le A_{rs}^{stitch} \tag{7}$$

for each  $v_r \in V_{Box^k}$ , Bend of  $X_f^i, Y_q^i$  lies in  $v_r$ 

$$\sum_{v_r} (X_f^i + Y_q^i) \le A_r^{stitch} \tag{8}$$

$$X_1^i, X_2^i, Y_1^j, Y_2^j \in \{0, 1\}$$
 (9)

Fig. 6. Generalized stitch-constrained ILP to route two-pin bend nets and two-pin segment present inside the  $k^{th}$  box

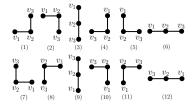


Fig. 7. Twelve possible patterns considered during Retrack based on Hadlock's algorithm [8] which uses detour number defined as the number of grid cells directed away from its target. In our method, for each vertex  $v \in G$ , instead of using only the detour number of the neighbouring vertices of v, we use four parameters, namely, detour number, available routing resource of the edge between v and its neighbour, available vertex capacity and Stitch Penalty. If the G-cells  $c_r$  and  $c_s$  are both stitch holding cells, then the Stitch Penalty  $\rho(v_r,v_s)=0$  number of tracks in stitch-unfriendly region  $\tau$ , and  $\sigma$ 0 otherwise. While exploring  $\sigma$ 1, we define a cost for each of its neighbours  $\sigma$ 2 as follows

$$cost(v_s) = A_{rs}^{stitch} + A_s^{stitch} - \rho(v_r, v_s)$$
 (10)

Our method stores the detour number and the cost of each explored vertex  $v_r$ . Then our maze router explores the neighbouring vertices  $v_s$  in non-increasing order of their cost.

The Retrack phase of our Stitch-constrained Maze router traces the path starting from the target vertex to the source vertex. In order to reduce bends and select the path with maximum available routing resources, we consider at a time these three vertices: vertex  $v_1$ , its neighbour  $v_2$  and  $v_2$ 's neighbour  $v_3$ . Initially,  $v_1=t$ . The neighbours are selected according to their detour numbers, i.e.,  $D[v_1] \geq D[v_2] \geq D[v_3]$ . If one of the neighbours, either  $v_2$  or  $v_3$ , is the source vertex then we terminate and return the path obtained.

The 12 patterns in which  $v_1, v_2$ , and  $v_3$  can appear in G are shown in Fig. 7. But not all the possibilities can appear always as some of the neighbouring vertices may not be visited during the exploration phase. For the patterns with bends, we discard a pattern if  $A_r^{stitch} = 0$ . For each possible pattern, its bottleneck cost is  $\min(cost(v_1), cost(v_2), cost(v_3))$ . For the patterns with a bend, we subtract a bend penalty from  $cost(v_2)$ . For patterns with bends and  $v_2$  representing a stitch holding cell, we subtract a stitch penalty from  $cost(v_2)$  also. We select the pattern with maximum bottleneck capacity. Next, we consider  $v_3$  as the initial vertex and iterate until the source vertex is reached.

# V. EXPERIMENTAL RESULTS

Our proposed stitch-avoiding global router is implemented in Java on a Linux workstation with 2.40 GHz Intel(R) Xeon(R) CPU and 32 GB RAM. We use FLUTE [6] to construct SMT and GLPK as the ILP solver. We consider the Faraday suite (Table I) in ICCAD'04 Mixed-size Placement Benchmarks [4] [9].

We perform placement by NTUplace3 [10] and then test our global router on its outputs. The distance between two stitch-lines is taken as  $15\times$  the routing pitch.

Table II shows the number of Steiner branches and Steiner points before and after performing SBS and SPS. The number of Steiner branches and points on stitch-lines are denoted by  $\#SB^{SL}$  and  $\#SP^{SL}$  respectively, and  $\#SB^{\tau}$  and  $\#SP^{\tau}$  correspond to the numbers in the stitch-unfriendly regions. HPWL gives the total half-perimeter wirelength. While SBS reduces  $\#SB^{SL}$ ,  $\#SP^{SL}$ ,  $\#SB^{\tau}$  and  $\#SP^{\tau}$  by about 70%, 59%, 44% and 31% respectively with an overhead of 0.14% increase in HPWL, SPS reduces these four parameters by 100%, 100%, 35% and 25% respectively with an overhead of 0.07% increase in HPWL.

Table III compares the performance of our proposed global router with a traditional global router called BoxRouter [5] and BoxRouter with reduced routing capacities for Stitch holding cells. Due to the unavailability of code for BoxRoute, we have implemented it in JAVA. #TVOF denotes the total number of vertex capacity overflow and #MVOF the maximum overflow of vertex capacity in a G-cell. WL denotes the total wirelength of global routing paths. We set  $\varphi$  to 1 in Eqn. 3 of stitch-constrained ILP, and bend penalty in our maze router as 1. Table III shows that our proposed method reduces  $\#SB^{SL}$  and  $\#SP^{SL}$  by 100%. Due to SBS and SPS, the density of Steiner points in the cells around the stitch holding cells increased. However, the values of TVOF and MVOF indicate that these increments did not exceed the vertex capacities. Moreover, our approach did not generate any overflow for RISC2 as in BoxRouter. Our proposed global router achieved 100% routability for all the nets with 0.28% and 16% overhead in wirelength and runtime respectively.

The effect of our global router on reduction of stitchline induced violations is evaluated by performing detailed routing with the traditional detailed router RegularRoute [11]. Here, we block vertical routing on the tracks that coincide with the stitch-lines to avoid vertical routing violations. As the source code of RegularRoute is unavailable, we have implemented it in JAVA. Table IV shows the comparison of our proposed stitch-avoiding global router followed by RegularRoute with Baseline Router I composed of traditional BoxRouter followed by RegularRoute and Baseline Router II composed of BoxRouter with reduced routing capacities of Stitch holding cells followed by RegularRoute. #VV, #SHP and #VRV denote the number of via violations, short polygons and vertical routing violations respectively. %Rout. denotes the routability in percentage. Due to the blocking of vertical routing on stitch-lines, #VRV is zero for both the Baseline routers and our proposed router.

Table IV demonstrates that the Baseline Router II does not reduce the stitch-line violations as much as Baseline

TABLE I FARADAY BENCHMARK CIRCUITS OF ICCAD04 [4]

Circuits	#Layers	$Size(\mu m^2)$	#Nets	#Pins
DMA	6	$408.4 \times 408.4$	13256	73982
DSP1	6	$706 \times 706$	28447	144872
DSP2	6	$642.8 \times 642.8$	28431	144703
RISC1	6	$1003.6 \times 1003.6$	34034	196677
RISC2	6	$959.6 \times 959.6$	34034	196670

TABLE II

NUMBER OF STEINER BRANCHES(SB) AND STEINER POINTS(SP) BEFORE AND AFTER PERFORMING SBS AND SPS

Circuits		Initial: I	Before SBS	S and SPS				Aft	er SBS		After SBS and SPS						
Circuits	$\#SB^{SL}$	$\#SP^{SL}$	$\#SB^{\tau}$	$\#SP^{\tau}$	HPWL(µm)	$\#SB^{SL}$	$\#SP^{SL}$	$\#SB^{\tau}$	$\#SP^{\tau}$	HPWL(µm)	CPU(ms)	$\#SB^{SL}$	$\#SP^{SL}$	$\#SB^{\tau}$	$\#SP^{\tau}$	HPWL(µm)	CPU(ms)
DMA	1522	1240	3904	3207	544183.62	494	525	2307	2327	545049.31	19	0	0	1500	1769	545577.02	14
DSP1	2184	1696	6157	4746	1143573.09	610	654	3258	3165	1145058.71	24	0	0	2103	2357	1145740.70	26
DSP2	2070	1591	6295	4803	1034884.39	552	597	3450	3255	1036381.16	29	0	0	2366	2468	1037014.39	23
RISC1	3854	3091	10082	8075	1669906.97	1195	1288	5702	5586	1672344.89	41	0	0	3712	4216	1673591.58	47
RISC2	3949	3183	10108	8105	1688466.52	1201	1307	5759	5709	1690820.61	44	0	0	3732	4312	1692085.39	41
Ratio	1.00	1.00	1.00	1.00	1.00	0.2984	0.4047	0.5605	0.6926	1.0014	-	0.00	0.00	0.6550	0.7545	1.0007	-

TABLE III
COMPARISON OF OUR PROPOSED STITCH-AVOIDING GLOBAL ROUTER WITH TRADITIONAL GLOBAL ROUTER

			BoxR	outer [5]					er [5] with	h Reduced	Capacities	Our Proposed Stitch-avoiding Global Router						
Circuits	$\#SB^{SL}$	$\#SP^{SL}$	TVOF	MVOF	$WL(\mu m)$	CPU(s)	$\#SB^{SL}$	$\#SP^{SL}$	TVOF	MVOF	$WL(\mu m)$	CPU(s)	$\#SB^{SL}$	$\#SP^{SL}$	TVOF	MVOF	$WL(\mu m)$	CPU(s)
DMA	1522	1240	0	0	556443.08	20.52	1522	1240	0	0	556443.08	20.52	0	0	0	0	558491.43	25.79
DSP1	2184	1696	0	0	1163966.87	45.72	2184	1696	0	0	1163974.86	49.19	0	0	0	0	1166902.24	53.19
DSP2	2070	1591	0	0	1057605.85	45.45	2070	1591	0	0	1057635.54	46.85	0	0	0	0	1060317.83	53.20
RISC1	3854	3091	0	0	1705038.18	81.83	3854	3091	0	0	1705102.18	90.68	0	0	0	0	1709656.30	91.80
RISC2	3949	3183	1	4	1720034.83	77.29	3949	3183	0	0	1720050.82	87.54	0	0	0	0	1724911.15	92.39
Ratio	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.00	1.1005	0.00	0.00	0.00	0.00	1.0028	1.1682

TABLE IV
EFFECTIVENESS OF THE PROPOSED STITCH-AVOIDING GLOBAL ROUTER AFTER DETAILED ROUTING

		D.		4 Y .		,	D.	II . D.	-D [6]		O P P C C C C C C C C C C C C C C C C C						
			aseline Rou			ı		uter II : Bo			Our Proposed Stitch-avoiding Global Router						
	BoxRoute [5] and RegularRoute [11]						duced Capa	acities and l	RegularRou	ite [11]	and RegularRoute [11]						
Circuits	#VV	#SHP	#VRV	%Rout.	CPU(Sec.)	#VV	#SHP	#VRV	%Rout.	CPU(Sec.)	#VV	#SHP	#VRV	%Rout.	CPU(Sec.)		
DMA	3589	1626	0	95.94	421	3587	1629	0	95.85	406	2990	1513	0	96.90	406		
DSP1	7469	3496	0	96.56	1419	7453	3502	0	96.59	1418	6225	3246	0	97.11	1413		
DSP2	7410	3462	0	96.69	1296	7408	3480	0	96.71	1304	6227	3220	0	97.74	1303		
RISC1	10799	5246	0	95.92	3016	10798	5264	0	95.95	3039	8778	4993	0	96.09	3035		
RISC2	10934	5565	0	96.09	2944	10939	5537	0	96.18	2986	8891	5218	0	96.48	2955		
Ratio	1.00	1.00	-	1.00	1.00	1.002	1.0008	-	1.004	1.006	0.8236	0.9378	-	1.006	1.0017		

Router I. This indicates that it is not possible to reduce stitch-line violations only by the traditional BoxRouter with reduced routing capacities of the stitch holding cells. However, Table IV also demonstrates that our proposed Stitch-avoiding global router followed by detailed routing with RegularRoute, achieved on average a reduction of 17.3% and 6.21% in #VV and #SHP respectively as compared to the Baseline Router I. Further, at termination, the proposed method attained a reduction of 1.89% on average in total routed wirelength with 0.6% improvement in the %Rout. compared to the results of the Baseline router I. In [2] and [3], the placement tools used to place the circuits of Faraday benchmark suite were not disclosed. As placement affects the number of stitch-line violations, we cannot compare our results with those by [2] and [3] without this information.

#### VI. CONCLUDING REMARKS

This paper presents a stitch-avoiding global router for MEBL. Different shifting mechanisms are imposed along with stitch-constrained ILP and stitch-constrained maze routing to route nets with minimum stitch-line violations. Experimental results show significant reductions in the stitch-line violations due to our stitch-avoiding global routing. The performance of the proposed Stitch-avoiding global router followed by other state-of-the-art commercial and academic detailed routers needs to be analyzed for further improvements. A stitch-avoiding detailed router can further reduce the stitch-line violations. Hence, designing an efficient stitch-avoiding detailed router is in the future scope of this work.

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